TOSHIBA GATE TURN-OFF THYRISTOR LOW SNUBBER TYPE

SG4000EX26

INVERTER APPLICATION

Unit in mm

Repetitive Peak Off-State Voltage: VDRM=2500V (Note 1)

R.M.S On-State Current $: I_{T(RMS)} = 2000A (T_f = 76^{\circ}C)$

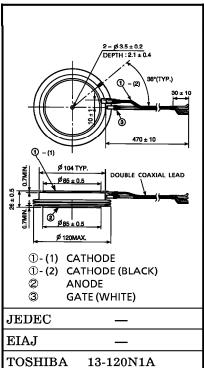
Peak Turn-Off Current $: I_{TGQM} = 4000A$

Critical Rate of Rise of On-State Current : di/dt=500A/μs

Critical Rate of Rise of Off-State Voltage: dv/dt=1000V/\mu s

MAXIMUM RATINGS

CHARACTERISTIC	SYMBOL	RATING	UNIT
Repetitive Peak Off-State Voltage (Note 1)	$v_{ m DRM}$	2500	V
Repetitive Peak Reverse Voltage	V_{RRM}	RRM 16	
Peak Turn-Off Current (Note 2)	ITGQM	4000	Α
R.M.S On-State Current (Note 3)	I _T (RMS)	2000	Α
Peak One Cycle Surge On-State Current (Non Repetitive, 10ms-Width Half Sine Wave)	I_{TSM}	30000	Α
Critical Rate of Rise of On-State Current (Note 4)	di/dt	500	A/µs
Peak Forward Gate Current	IFGM	100	Α
Average Forward Gate Power Dissipation	P _{FG (AV)}	50	W
Average Reverse Gate Power Dissipation	PRG (AV)	300	W
R.M.S Gate Current (Note 5)	I _{G (RMS)}	84	Α
Peak Reverse Gate Voltage (at Static)	v_{RGM}	16	V
Operating Junction Temperature Range	$\mathrm{T_{j}}$	-40~125	°C
Storage Temperature Range	$\mathrm{T_{stg}}$	-40~150	°C
Mounting Force	_	38.2±5.9	kN



Weight: 1700g

Note 1 $V_{GK} = -2V$

 $V_{DM}^{\rm CS}=6\mu F,~R_S=5\Omega,~di_{GQ}/dt=50A/\mu s,~V_{DSP}\leq 1000V,~L_S\leq 0.15\mu H$ 50Hz Half Sine Waveform at $T_f=76^{\circ}C$ Note 2

Note 3

Note 4 $V_D = 1/2V_{DRM}$, $I_{GM} = 25A$

Ambient Temperature of coaxial gate-cathode lead=90°C Note 5

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ELECTRICAL CHARACTERISTICS

CHARACTERISTIC	SYMBOL	TEST CONDITION		MIN.	TYP.	MAX.	UNIT
Repetitive Peak Off-State Current	$I_{ m DRM}$	V_{DRM} =RATED, V_{GK} = -2V, T_j =125°C		_	_	100	mA
Repetitive Peak Reverse Current	I_{RRM}	V_{RRM} =RATED, T_j =125°C		_	_	10	mA
Repetitive Peak Reverse Gate Current	$I_{ m RGM}$	V_{RGM} =16V, T_j =125°C		_	1	10	mA
Peak On-State Voltage	$ ho_{ ext{TM}}$	I _{TM} =4000A, T _j =125°C			l	3.5	V
Gate Trigger Voltage	v_{GT}		$T_j = -40^{\circ}C$	_	I	_	V
		$V_D = 24V,$ $R_L = 0.1\Omega$	$T_j = 25$ °C	_	I	1.50	
Gate Trigger Current	I_{GT}		$T_j = -40^{\circ}C$	_	_	_	A
			$T_j = 25$ °C	_	_	4.0	
Turn-On Delay Time	^t d	$V_{D}\!=\!1/2V_{DRM}, \ di/dt\!=\!500A/\mu s, \ I_{GM}\!=\!25A, \ T_{j}\!=\!25^{\circ}C$		_	-	3	μs
Turn-On Time	tgt			_	_	10	μs
Critical Rate of Rise of Off- State Voltage	dv / dt	$V_{\mathrm{DRM}} = 2/3\mathrm{RATED},$ $T_{\mathrm{j}} = 125^{\circ}\mathrm{C}, \ V_{\mathrm{GK}} = -10\mathrm{V}$		1000	_	_	V/μs
Storage Time	t_{S}	$\begin{split} &\mathbf{I_{TGQ}}\!=\!4000\mathrm{A},\\ &\mathbf{V_{DM}}\!=\!2500\mathrm{V},\\ &\mathbf{V_{D}}\!=\!1/2\mathrm{V_{DRM}},\\ &\mathbf{di_{GQ}}/\mathbf{dt}\!=\!50\mathrm{A}/\mu\mathrm{s},\\ &\mathbf{C_{S}}\!=\!6\mu\mathrm{F},\ \mathrm{R_{S}}\!=\!5\Omega,\\ &\mathbf{T_{j}}\!=\!125^{\circ}\mathrm{C},\ \mathbf{L_{S}}\!\!\leq\!0.15\mu\mathrm{H} \end{split}$		_	_	30	μs
Gate Turn-Off Time	$t_{ m gq}$			_	_	32	μs
Tail Time	t _{tail}			_	_	150	μs
Gate Turn-Off Current	I_{GQ}			_	850	_	A
Thermal Resistance (Junction to Fin)	R _{th (j-f)}	DC		_		0.011	°C/W